

<b>Notice of References Cited</b>	Application/Control No. 10/578,514	Applicant(s)/Patent Under Reexamination CHANG-HAE ET AL.	
	Examiner Matthew E. Hoban	Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,093,346	07-2000	Xiao et al.	252/301.4F
*	C	US-2007/0012931	01-2007	Lee et al.	257/089
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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